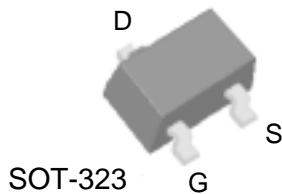


N-channel Enhancement-mode Power MOSFET

PRODUCT SUMMARY

BV _{DSS}	50V
R _{DS(ON)}	3Ω
I _D	250mA

 Pb-free; RoHS-compliant SOT-323



DESCRIPTION

The SSM7002EGU achieves fast switching performance with low gate charge without a complex drive circuit. It is suitable for low voltage applications such as small converters and general load-switching circuits.

The SSM7002EGU is supplied in a RoHS-compliant SOT-323 package, which is widely used for low-power commercial and industrial surface mount applications where a small footprint is required.

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Units
V _{DS}	Drain-source voltage	50	V
V _{GS}	Gate-source voltage	± 20	V
I _D	Continuous drain current ³ , T _A = 25°C	250	mA
I _{SD}	Source-drain diode current	115	mA
I _{DM}	Pulsed drain current ^{1,2}	1.0	A
P _D	Total power dissipation ³ , T _A = 25°C	200	mW
	T _A = 75°C	120	mW
T _{STG}	Storage temperature range	-55 to 150	°C
T _J	Operating junction temperature range	-55 to 150	°C

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Units
R _{θJA}	Maximum thermal resistance, junction-ambient ³	625	°C/W

Notes:

1. Pulse width must be limited to avoid exceeding the maximum junction temperature of 150°C.
2. Pulse width <300us, duty cycle <2%.
3. Mounted on FR4 board

ELECTRICAL CHARACTERISTICS (at $T_j = 25^\circ\text{C}$, unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-source breakdown voltage	$V_{\text{GS}}=0\text{V}$, $I_{\text{D}}=10\text{uA}$	50	-	-	V
$I_{\text{D}(\text{ON})}$	On-state drain current	$V_{\text{DS}}=7\text{V}$, $V_{\text{GS}}=10\text{V}$	500	-	-	mA
$R_{\text{DS}(\text{ON})}$	Static drain-source on-resistance	$V_{\text{GS}}=10\text{V}$, $I_{\text{D}}=250\text{mA}$	-	-	3	Ω
		$V_{\text{GS}}=5\text{V}$, $I_{\text{D}}=50\text{mA}$	-	-	4	Ω
$V_{\text{GS}(\text{th})}$	Gate threshold voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{D}}=250\text{uA}$	1	-	2.5	V
g_{fs}	Forward transconductance	$V_{\text{DS}}=7\text{V}$, $I_{\text{D}}=200\text{mA}$	80	-	-	mS
I_{DSS}	Drain-source leakage current	$V_{\text{DS}}=50\text{V}$, $V_{\text{GS}}=0\text{V}$	-	-	1.0	uA
I_{GSS}	Gate-source leakage current	$V_{\text{GS}}=\pm 20\text{V}$	-	-	± 100	nA
$t_{\text{d}(\text{on})}$	Turn-on delay time ²	$V_{\text{DS}}=30\text{V}$	-	7.5	20	ns
t_r	Rise time	$I_{\text{D}}=100\text{mA}$	-	6	-	ns
$t_{\text{d}(\text{off})}$	Turn-off delay time	$R_{\text{G}}=10\Omega$, $V_{\text{GEN}}=10\text{V}$	-	7.5	20	ns
t_f	Fall time		-	3	-	ns
C_{iss}	Input capacitance	$V_{\text{GS}}=0\text{V}$	-	19	50	pF
C_{oss}	Output capacitance	$V_{\text{DS}}=25\text{V}$	-	10	25	pF
C_{rss}	Reverse transfer capacitance	$f=1.0\text{MHz}$	-	3	5	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward voltage ²	$I_{\text{S}}=115\text{mA}$, $V_{\text{GS}}=0\text{V}$	-	0.76	1.5	V

Notes:

- 1.Pulse width must be limited to avoid exceeding the maximum junction temperature of 150°C .
- 2.Pulse width <300us, duty cycle <2%.

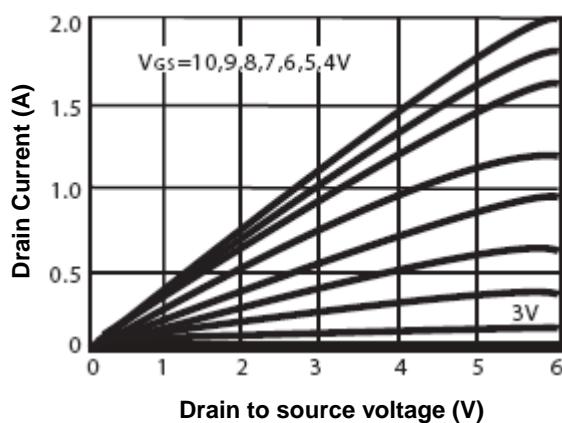


Fig 1. Typical output characteristics

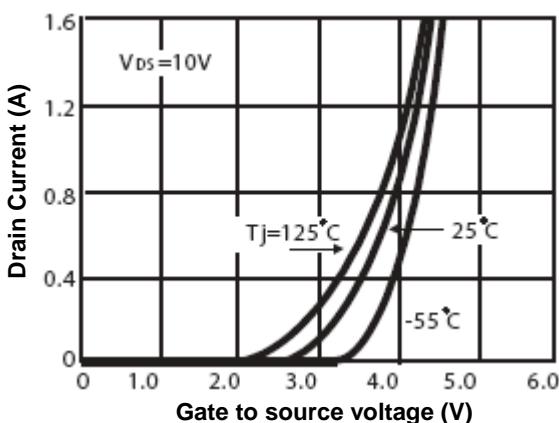


Fig 2. Typical transfer characteristics

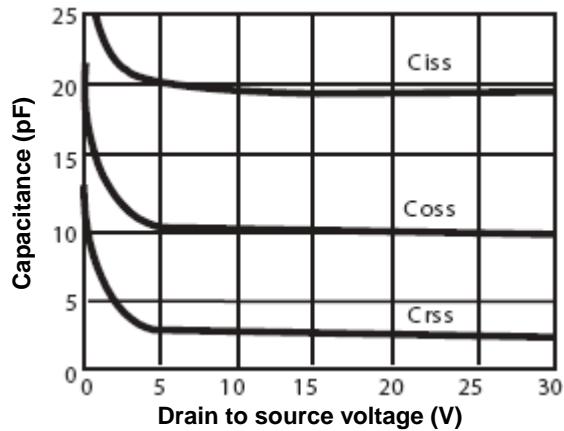


Fig 3. Typical Capacitance

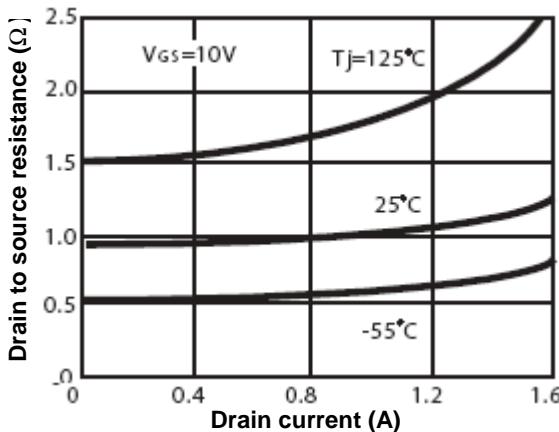


Fig 4. Normalized on-resistance
vs. junction temperature

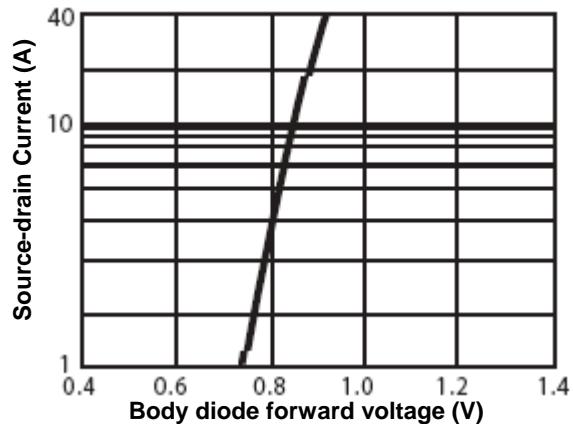


Fig 5. Forward characteristics of
the reverse diode

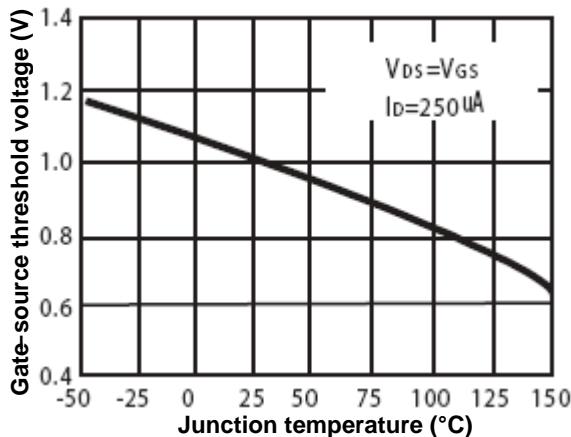
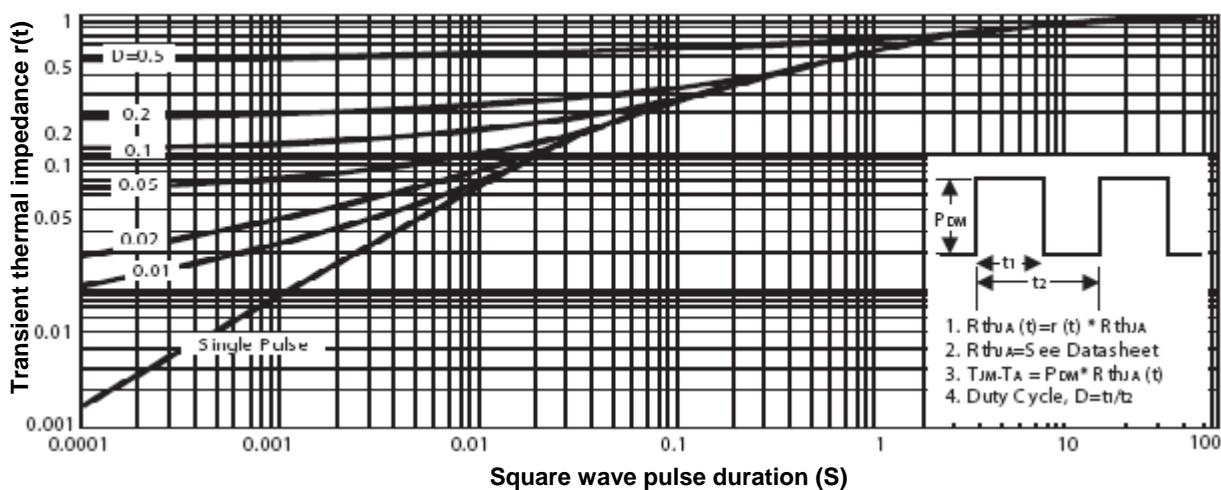
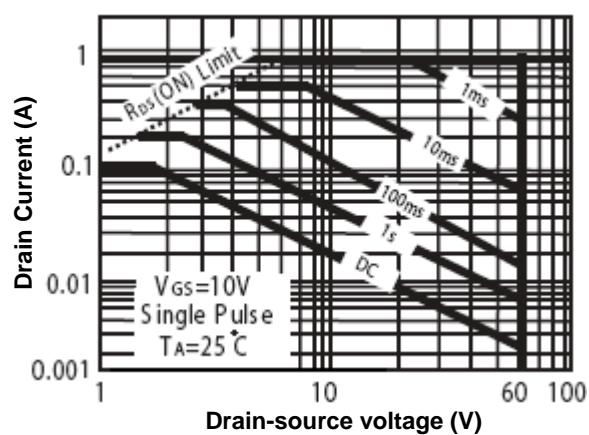
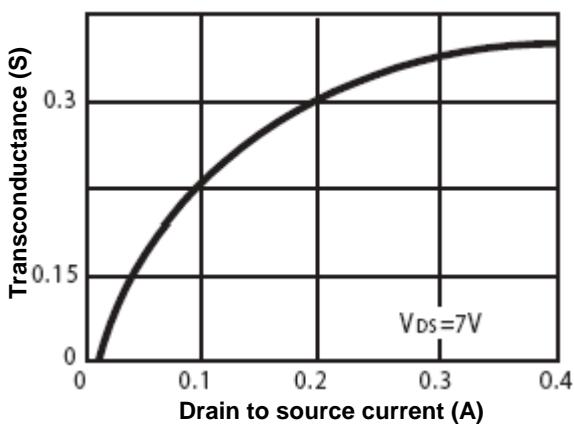
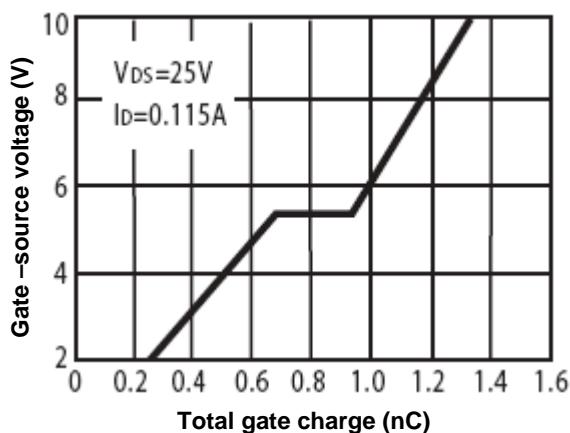
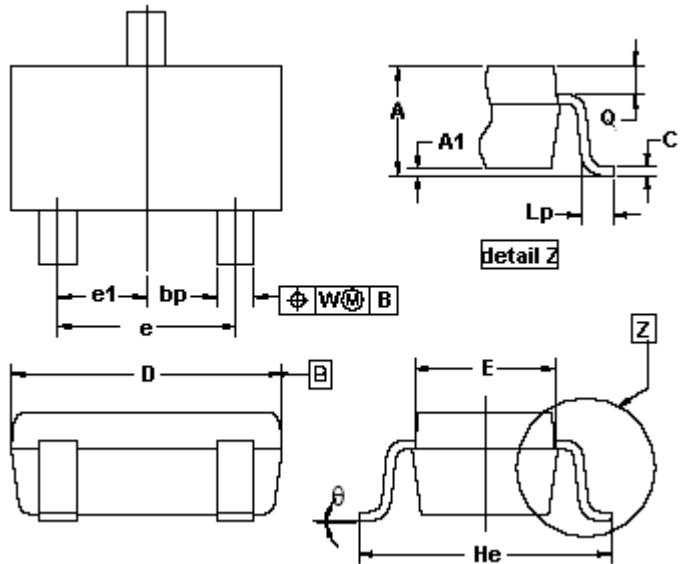


Fig 6. Gate threshold voltage vs.
junction temperature



PHYSICAL DIMENSIONS

SOT-323



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.80	1.10	0.0315	0.0433
A1	--	0.10	--	0.0039
bp	0.30	0.40	0.0118	0.0157
C	0.10	0.25	0.0039	0.0098
D	1.80	2.20	0.0709	0.0866
E	1.15	1.35	0.0453	0.0531
e	1.30	--	0.0512	--
e1	0.65	--	0.0256	--
He	2.00	2.20	0.0787	0.0866
Lp	0.15	0.45	0.0059	0.0177
Q	0.13	0.23	0.0051	0.0091
W	0.20	--	0.0079	--
Θ	10°	--	10°	--

PACKING: Moisture sensitivity level MSL3

3000 pcs in antistatic tape on a reel packed in a moisture barrier bag (MBB).

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